

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/483,712	01/14/2000	Tongbi Jiang	3815US (98-0670)	8743
75	590 10/12/2005		EXAMINER	
Joseph A Walkowski			WARREN, MATTHEW E	
TRASK BRITT & ROSSA		ART UNIT	PAPER NUMBER	
P O Box 2550 Salt Lake City, UT 84110			2815	

DATE MAILED: 10/12/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

			AIC			
:	Application No.	Applicant(s)	*			
	09/483,712	JIANG ET AL.	·			
Office Action Summary	Examiner	Art Unit				
	Matthew E. Warren	2815				
The MAILING DATE of this communication Period for Reply	n appears on the cover sheet wit	h the correspondence addre	ess			
A SHORTENED STATUTORY PERIOD FOR R WHICHEVER IS LONGER, FROM THE MAILIN - Extensions of time may be available under the provisions of 37 C after SIX (6) MONTHS from the mailing date of this communicatic - If NO period for reply is specified above, the maximum statutory p - Failure to reply within the set or extended period for reply will, by Any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b).	NG DATE OF THIS COMMUNIC FR 1.136(a). In no event, however, may a re on. period will apply and will expire SIX (6) MONT statute, cause the application to become ABA	ATION. ply be timely filed "HS from the mailing date of this commandoned (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on	19 July 2005.					
2a)⊠ This action is FINAL . 2b)□	This action is FINAL . 2b) ☐ This action is non-final.					
	3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice un	der <i>Ex parte Quayle</i> , 1935 C.D.	11, 453 O.G. 213.				
Disposition of Claims						
4) Claim(s) is/are pending in the appl 4a) Of the above claim(s) is/are wit 5) Claim(s) is/are allowed. 6) Claim(s) is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction as	hdrawn from consideration.					
Application Papers						
9) The specification is objected to by the Exa 10) The drawing(s) filed on is/are: a) Applicant may not request that any objection t Replacement drawing sheet(s) including the c 11) The oath or declaration is objected to by the	accepted or b) objected to be to the drawing(s) be held in abeyand orrection is required if the drawing(s)	ce. See 37 CFR 1.85(a). s) is objected to. See 37 CFR				
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for fo a) All b) Some * c) None of: 1. Certified copies of the priority document of the priority document of the priority document of the certified copies of the application from the International B * See the attached detailed Office action for	ments have been received. ments have been received in Ap e priority documents have been i ureau (PCT Rule 17.2(a)).	oplication No received in this National St	age			
Attachment(s) 1) Notice of References Cited (PTO-892)		ummary (PTO-413))/Mail Date				
 2) Notice of Draftsperson's Patent Drawing Review (PTO-94 3) Information Disclosure Statement(s) (PTO-1449 or PTO/S Paper No(s)/Mail Date 	· · · · · · · · · · · · · · · · · · ·	formal Patent Application (PTO-1	52)			

DETAILED ACTION

This Office Action is in response to the Amendment filed on July 8, 2005.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 1-16 and 19 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention. Claims 1 and 2 recite the limitation that the "intermediate structure is free of an encapsulant material... wherein the carrier bond is configured to extend beyond an outer surface of the encapsulant material." This limitation is vague because of limitation of the carrier bond extending beyond an outer surface of the encapsulant material. If the encapsulant material is not present in the intermediate structure, then how do the carrier bonds extend beyond the encapsulant material?

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Page 3

Art Unit: 2815

Claims 1, 2, 5-9, and 13-16, and 19, as far as understood, are rejected under 35 U.S.C. 103(a) as being unpatentable over King et al. (US 5,677,566) in view of Havens et al. (US Pub 2001/0011773 A1).

In re claims 1 and 2, King et al. shows (figs. 6-8) an intermediate structure in the fabrication of a chip scale package comprising: a semiconductor die (14) having an active surface having a plurality of bond pads (18) thereon; a dielectric element (16) having an upper surface and a lower surface, the lower surface of the dielectric element attached to a portion of the active surface of said-the semiconductor die; a plurality of conductive lead frame members (13) having inner ends laterally spaced from said the plurality of bond pads, each conductive lead frame member of the plurality of conductive lead frame members having an upper surface (12) and a lower surface, a portion of the lower surface of each conductive lead frame member of the plurality of conductive lead frame members being attached to a portion of the upper surface of the dielectric element (16) for connecting each conductive lead frame member of the plurality of conductive lead frame members to the active surface of the semiconductor die; a plurality of discrete conductive bond members (22), at least one discrete conductive bond member of the plurality of conductive bond members connecting the inner end of each conductive lead frame member of said-the plurality of conductive lead frame members to at least one bond pad of the plurality of bond pads on the active surface of the semiconductor die; a plurality of conductive carrier bonds (28), at least one carrier bond of the plurality of conductive carrier bonds directly disposed on the upper surface of each conductive lead frame member of the plurality of conductive lead frame

members at a location remote from the inner end thereof and extending transversely from the upper surface thereof, and an encapsulating material (26) disposed about at least portions of the semiconductor die, about the dielectric element, between the active surface of the semiconductor die and the lower surface of a portion of each lead frame member of the plurality of conductive lead frame members, over outer ends of the lead frame members of the plurality, over the plurality of discrete conductive bond members and over a portion of each carrier bond of the plurality of conductive carrier bonds another portion of each carrier bond extending beyond an outer surface of the encapsulating material. King shows all of the elements of the claims except the intermediate structure free of encapsulant material. Havens et al. discloses [0025-0028] a package process in which an intermediate structure in the fabrication of a chip scale structure comprises the intermediate structure being free of encapsulant. The circuit substrate, ILD layers, conductive layers, and external conductors (solder balls 6) are formed prior to the encapsulation process. The encapsulant material is formed last to reduce moisture and improve product yield. With respect to the limitations of the claims concerning the carrier bonds and the intermediate structure being configured to be encapsulated and extend beyond the encapsulant, it has been held that the recitation that an element is "adapted to" perform a function is not a positive limitation but only requires the ability to so perform. It does not constitute a limitation in any patentable sense. In re Hutchison, 69 USPQ 138. Havens does however show (fig. 4A) that the carrier bonds (6) are configured such that they would extend beyond the encapsulant (23). Therefore, it would have been obvious to one of ordinary skill in the art at the time

the invention was made to modify the intermediate package structure of King by forming the intermediate structure free of encapsulant as taught by Havens to reduce the amount of moisture in the package during the subsequent encapsulation process and ultimately improving the device yield.

In re claim 5, King et al. shows (fig. 3) wherein the upper surface and lower surface of the dielectric element are attached respectively to a portion of the lower surface of each conductive lead frame member of the plurality of conductive lead frame members and a portion of the active surface of the semiconductor die connecting portions of said the plurality of conductive lead frame members and to portions of the active surface of the semiconductor die.

In re claims 6-9, and 13-16, and 19 King discloses (col. 3, lines 10-21) wherein the plurality of conductive lead frame members comprises a plurality of lead fingers. The plurality of conductive lead frame members comprises a conductive metal. The plurality of discrete conductive bond members comprises a conductive metal. The plurality of discrete conductive bond members comprises bond wires. The plurality of conductive carrier bonds includes metal. King also shows (fig. 4) that the plurality of conductive carrier bonds is selectively located on the upper surfaces of the plurality of conductive lead frame members forming an array over the active surface of the semiconductor die and that the plurality of conductive carrier bonds comprises solder balls.

In re claim 19, King shows (fig. 3) that each conductive carrier bond of the plurality of conductive carrier bonds further comprises an upper portion and a lower portion, the lower portion of a-each conductive carrier bond being attached to the upper

Application/Control Number: 09/483,712

Art Unit: 2815

surface of an associated conductive lead frame member of the plurality of conductive lead frame members. The encapsulating material is disposed only about the lower portions of the plurality of conductive carrier bonds.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 3, 4, and 10-12 are rejected under 35 U.S.C. 103(a) as being unpatentable over King et al. (US 5,677,566) in view of Havens et al. (US Pub 2001/0011773 A1) as applied to claims 2 and 9 above and further in view of Lee et al. (US 5,894,107).

In re claims 3, 4, and 10-12, King does not specifically disclose the materials of the dielectric element, the materials of the bond wires, or the types of conductive bond members, but such elements are not patentably distinguishable over the cited art because such materials are well known in the art. However, Lee et al. discloses a (col. 4, line 60 – col. 5, line 20) a chip scale package in which a dielectric element may be any adhesive including polyamide tape or films. The conductive bond members may comprise any conventional connecting members including metal, wires, gold, TAB or thermocompression bonds. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the materials of King and

Havens by using specific materials of polyimide for the dielectric element, gold wires, and TAB or thermocompression bonds for the discrete conductive bond members as taught by Lee to provide well known, suitable conductor connections to form the chip scale package.

Response to Arguments

Applicant's arguments with respect to claims 1-16, and 19 have been considered but are most in view of the new ground(s) of rejection.

Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Application/Control Number: 09/483,712

Art Unit: 2815

Page 8

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew E. Warren whose telephone number is (571) 272-1737. The examiner can normally be reached on Mon-Thur and alternating Fri 9:00-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (571) 272-1664. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MEW MEW

October 4, 2005

TOM THOMAS
SUPERVISORY PATENT EXAMINER